Se	arch No	tes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/798,271	LEE ET AL.
Examiner	Art Unit
Hung Q. Dang	2621

	SEAR	CHED	
Class	Subclass	Date	Examiner
386	95, 105	8/8/2007	HQD
369	59.25, 275.3	8/8/2007	HQD
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TNI	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventors' Names Search	8/8/2007	HQD
USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	8/6/2007- 8/8/2007	HQD
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